

DOSEMI**IGBT****DG200A12T6B****1200V/200A IGBT with Diode****General Description**

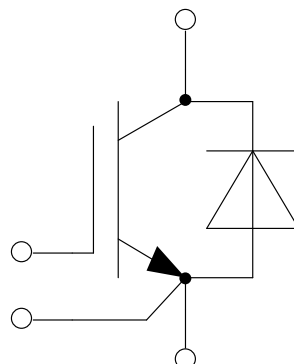
DOSEMI IGBT Power Discrete provides ultra low conduction loss as well as low switching loss. They are designed for the applications such as general inverters and UPS.

Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- Low switching loss
- Maximum junction temperature 175°C
- $V_{CE(sat)}$ with positive temperature coefficient
- Fast & soft reverse recovery anti-parallel FWD
- Isolated heatsink using Si_3N_4 AMB technology
- ROHS

Typical Applications

- Inverter for motor drive
- AC and DC servo drive amplifier
- Uninterruptible power supply

Equivalent Circuit Schematic

Absolute Maximum Ratings $T_C=25^{\circ}\text{C}$ unless otherwise noted**IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=100^{\circ}\text{C}$	400 200	A
I_{CM}	Pulsed Collector Current t_p limited by T_{jmax}	400	A
P_D	Maximum Power Dissipation @ $T_{vj}=175^{\circ}\text{C}$	1470	W

Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1200	V
I_F	Diode Continuous Forward Current	200	A
I_{FM}	Diode Maximum Forward Current t_p limited by T_{jmax}	400	A

Discrete

Symbol	Description	Values	Unit
T_{vjmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{vioP}	Operating Junction Temperature	-40 to +175	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	2500	V

IGBT Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=200\text{A}, V_{GE}=15\text{V}, T_{vj}=25^{\circ}\text{C}$		1.55	2.00	V
		$I_C=200\text{A}, V_{GE}=15\text{V}, T_{vj}=150^{\circ}\text{C}$		1.90		
		$I_C=200\text{A}, V_{GE}=15\text{V}, T_{vj}=175^{\circ}\text{C}$		1.95		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=5.2\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^{\circ}\text{C}$		6.4		V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			1.0	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			400	nA
R_{Gint}	Internal Gate Resistance			4.0		Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		26.7		nF
C_{oes}	Output Capacitance			0.52		nF
C_{res}	Reverse Transfer Capacitance			0.18		nF
Q_G	Gate Charge	$V_{GE}=-8\dots+15\text{V}$		1.77		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=800\text{V}, I_C=200\text{A}, R_G=3.3\Omega, V_{GE}=-8/+15\text{V}, L_S=60\text{nH}, T_{vj}=25^{\circ}\text{C}$		290		ns
t_r	Rise Time			69		ns
$t_{d(off)}$	Turn-Off Delay Time			712		ns
t_f	Fall Time			58		ns
E_{on}	Turn-On Switching Loss			39.6		mJ
E_{off}	Turn-Off Switching Loss			18.7		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=800\text{V}, I_C=200\text{A}, R_G=3.3\Omega, V_{GE}=-8/+15\text{V}, L_S=60\text{nH}, T_{vj}=150^{\circ}\text{C}$		324		ns
t_r	Rise Time			97		ns
$t_{d(off)}$	Turn-Off Delay Time			836		ns
t_f	Fall Time			144		ns
E_{on}	Turn-On Switching Loss			54.3		mJ
E_{off}	Turn-Off Switching Loss			25.6		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=800\text{V}, I_C=200\text{A}, R_G=3.3\Omega, V_{GE}=-8/+15\text{V}, L_S=60\text{nH}, T_{vj}=175^{\circ}\text{C}$		331		ns
t_r	Rise Time			98		ns
$t_{d(off)}$	Turn-Off Delay Time			854		ns
t_f	Fall Time			146		ns
E_{on}	Turn-On Switching Loss			55.4		mJ
E_{off}	Turn-Off Switching Loss			26.4		mJ
I_{SC}	SC Data	$t_p \leq 6\mu\text{s}, V_{GE}=15\text{V}, T_{vj}=175^{\circ}\text{C}, V_{CC}=800\text{V}, V_{CEM} \leq 1200\text{V}$		700		A

Diode Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=200\text{A}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$		1.95	2.40	V
		$I_F=200\text{A}, V_{GE}=0\text{V}, T_{vj}=150^\circ\text{C}$		1.95		
		$I_F=200\text{A}, V_{GE}=0\text{V}, T_{vj}=175^\circ\text{C}$		1.90		
t_{rr}	Reverse Recovery Time	$V_R=800\text{V}, I_F=200\text{A},$ $-di/dt=1850\text{A}/\mu\text{s}, V_{GE}=-8\text{V}$ $L_S=60\text{nH}, T_{vj}=25^\circ\text{C}$		334		ns
Q_r	Recovered Charge			12.6		μC
I_{RM}	Peak Reverse Recovery Current			83		A
E_{rec}	Reverse Recovery Energy			3.86		mJ
t_{rr}	Reverse Recovery Time	$V_R=800\text{V}, I_F=200\text{A},$ $-di/dt=1400\text{A}/\mu\text{s}, V_{GE}=-8\text{V}$ $L_S=60\text{nH}, T_{vj}=150^\circ\text{C}$		474		ns
Q_r	Recovered Charge			21.7		μC
I_{RM}	Peak Reverse Recovery Current			89		A
E_{rec}	Reverse Recovery Energy			6.79		mJ
t_{rr}	Reverse Recovery Time	$V_R=800\text{V}, I_F=200\text{A},$ $-di/dt=1400\text{A}/\mu\text{s}, V_{GE}=-8\text{V}$ $L_S=60\text{nH}, T_{vj}=175^\circ\text{C}$		511		ns
Q_r	Recovered Charge			23.4		μC
I_{RM}	Peak Reverse Recovery Current			95		A
E_{rec}	Reverse Recovery Energy			7.34		mJ

Discrete Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
R_{thJC}	Junction-to-Case (per IGBT)			0.106	K/W
	Junction-to-Case (per Diode)			0.178	

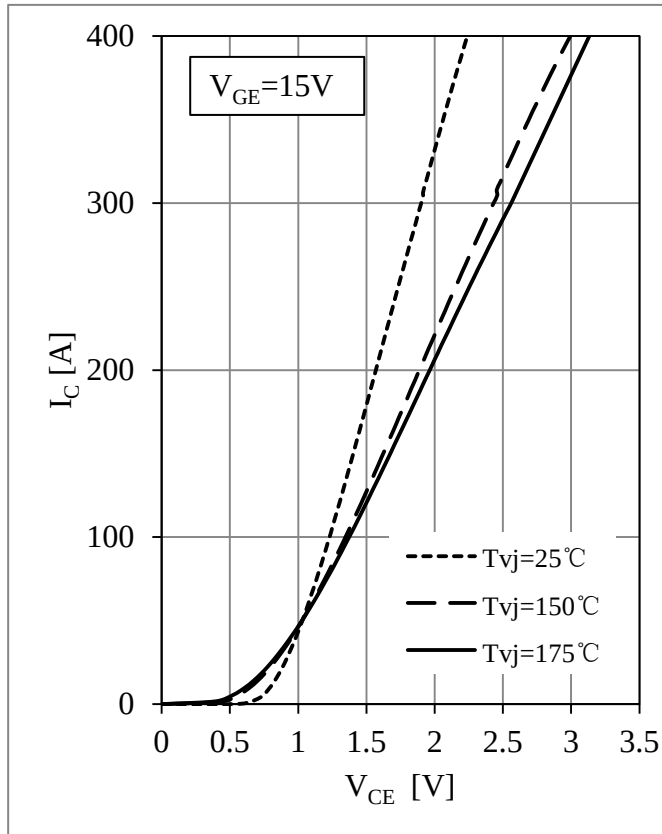


Fig 1. IGBT Output Characteristics

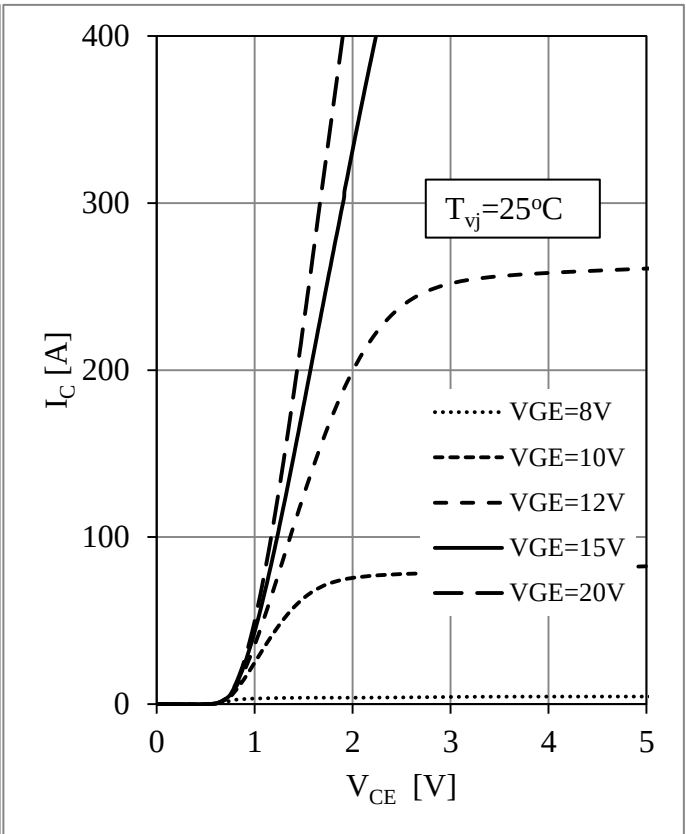


Fig 2. IGBT Output Characteristics

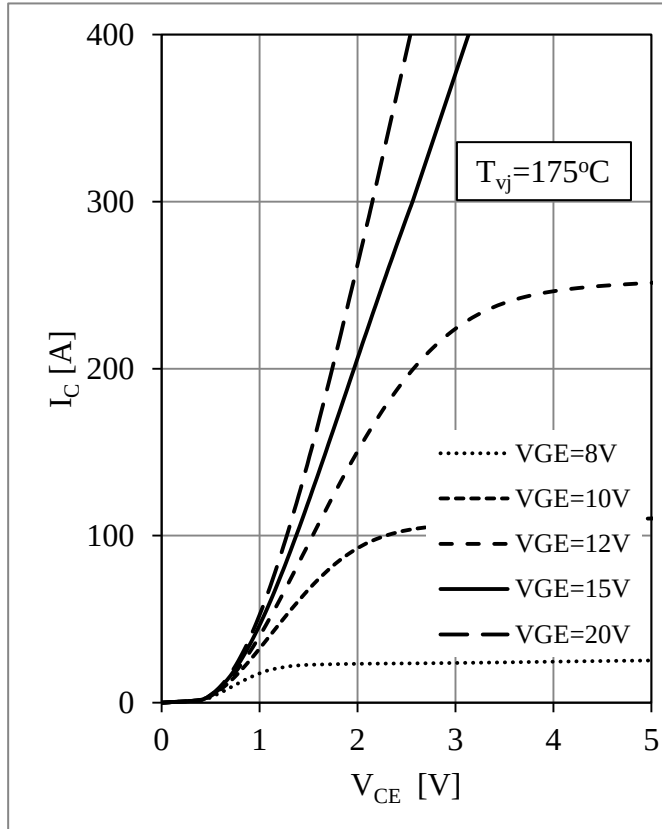


Fig 3. IGBT Output Characteristics

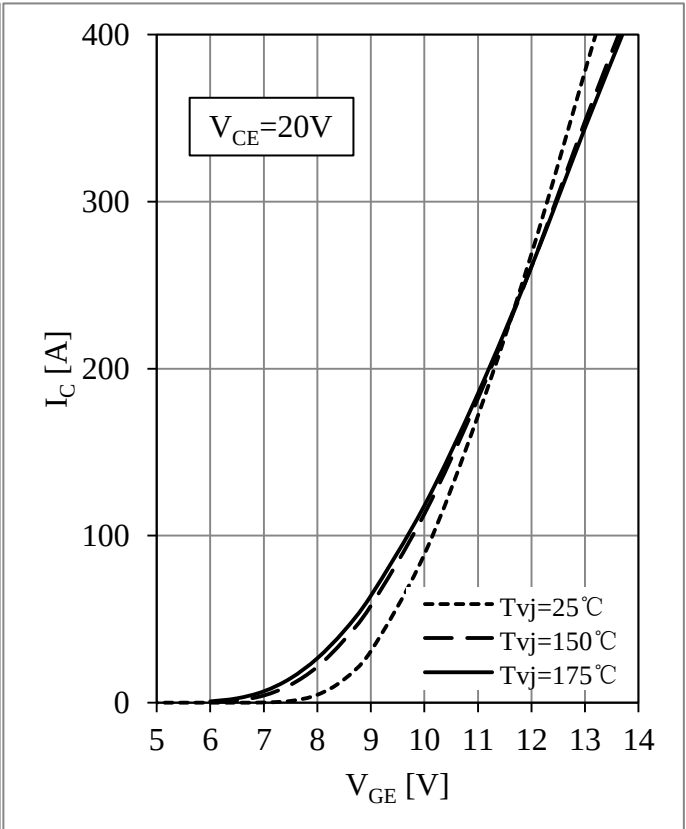
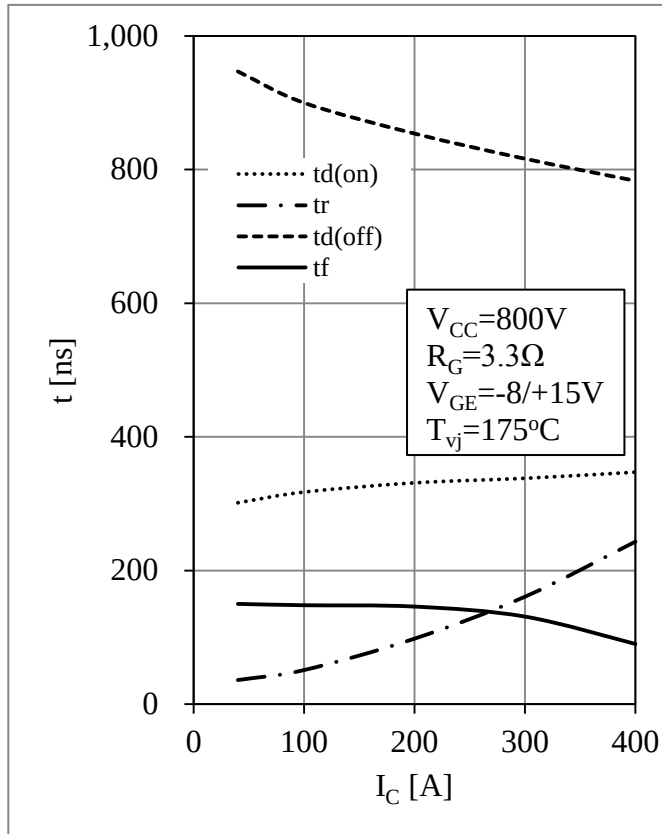
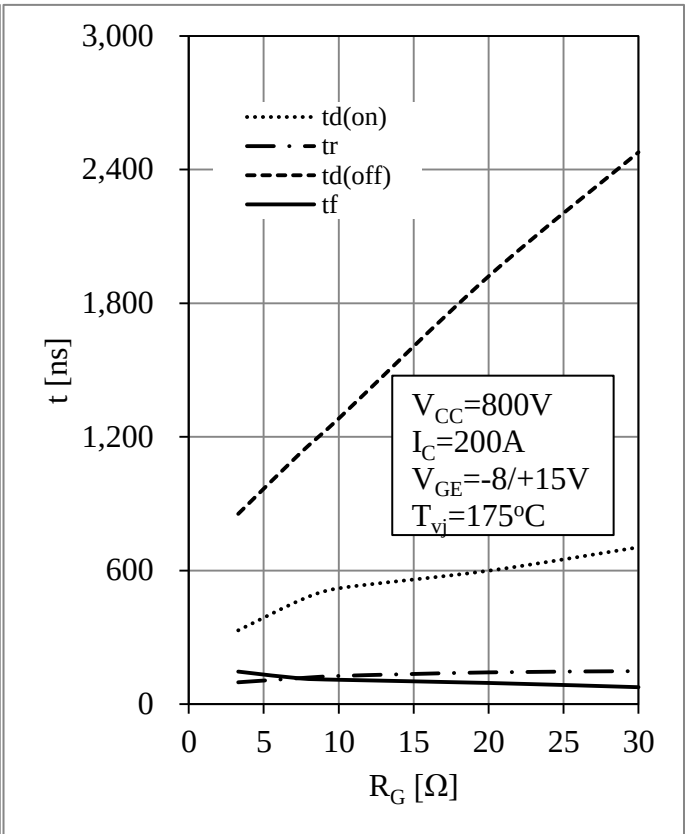
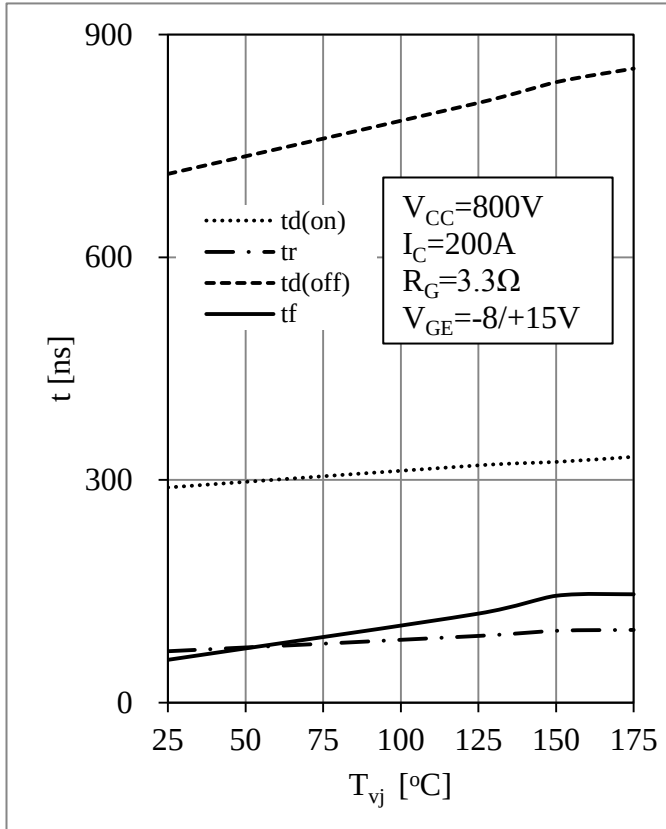
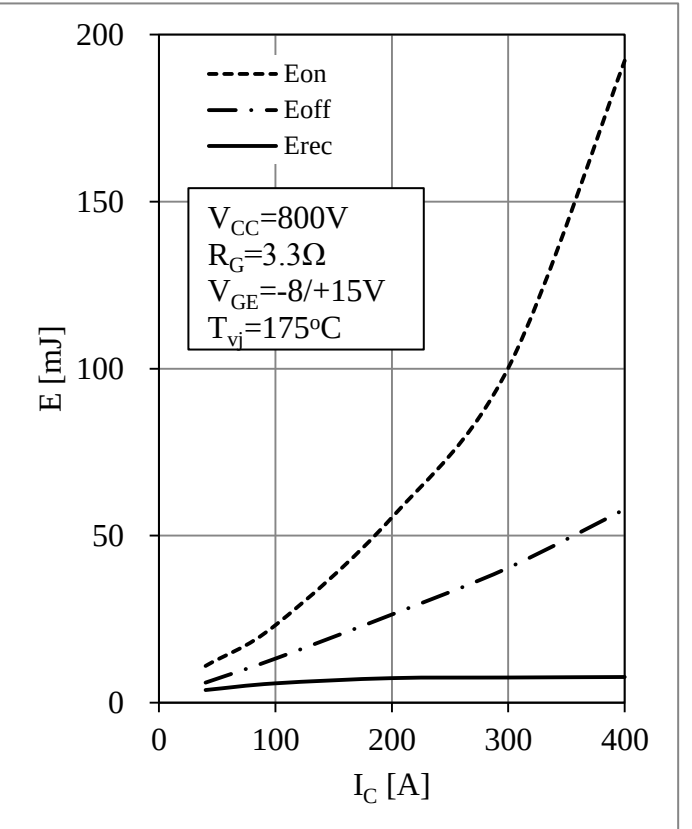


Fig 4. IGBT Transfer Characteristics

Fig 5. IGBT Switching Times as. I_C Fig 6. IGBT Switching Times as. R_G Fig 7. IGBT Switching Times vs. T_{vj} Fig 8. Switching Energy Loss vs. I_C

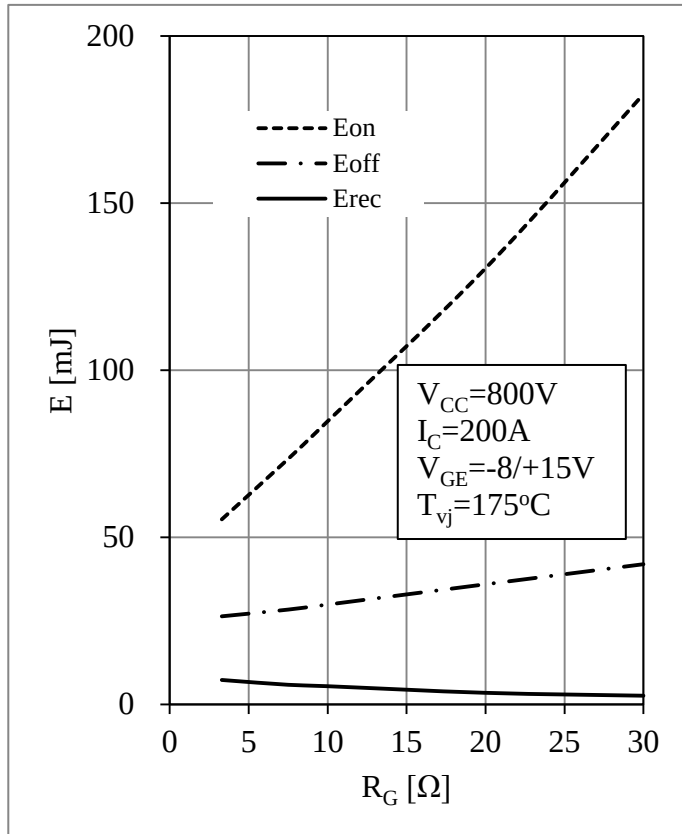
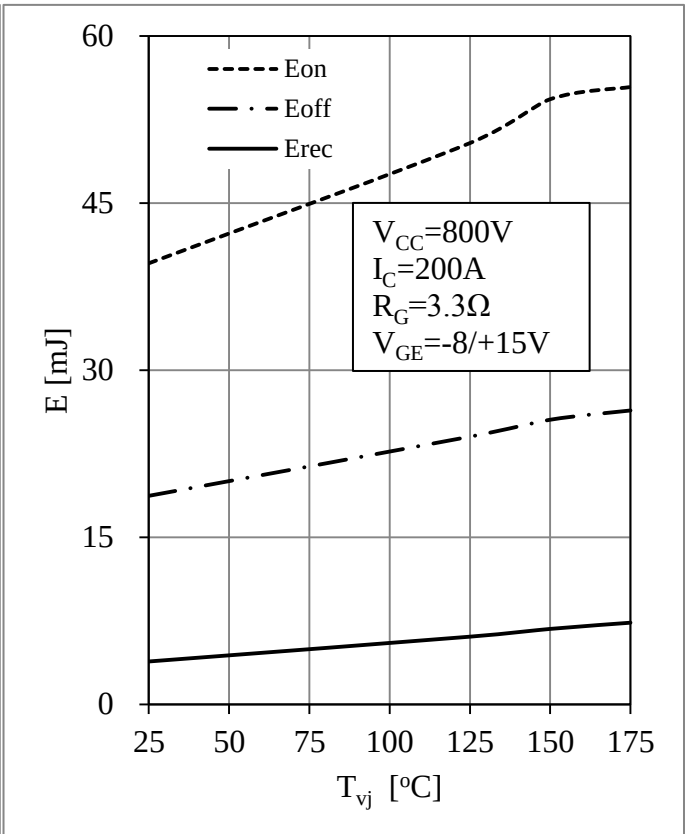
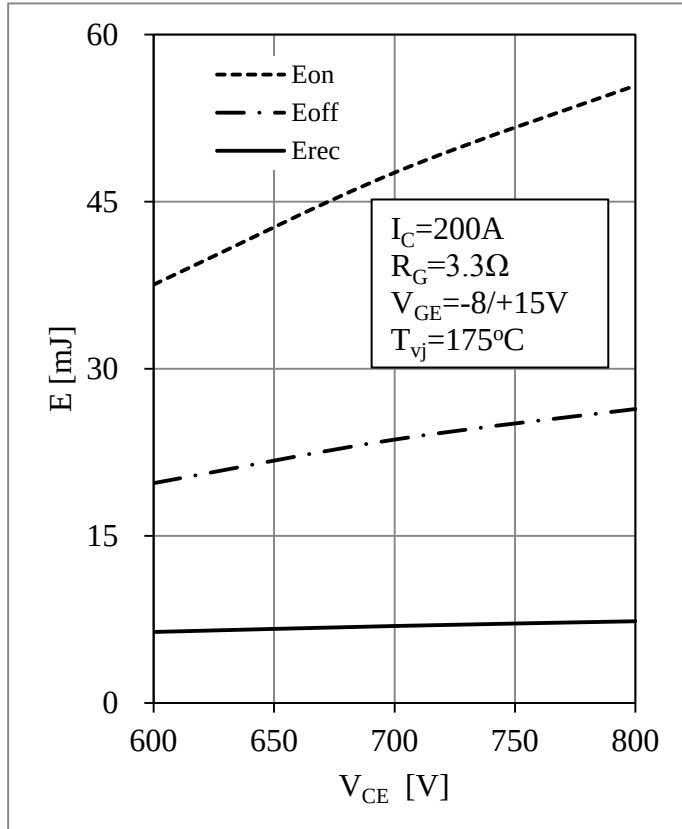
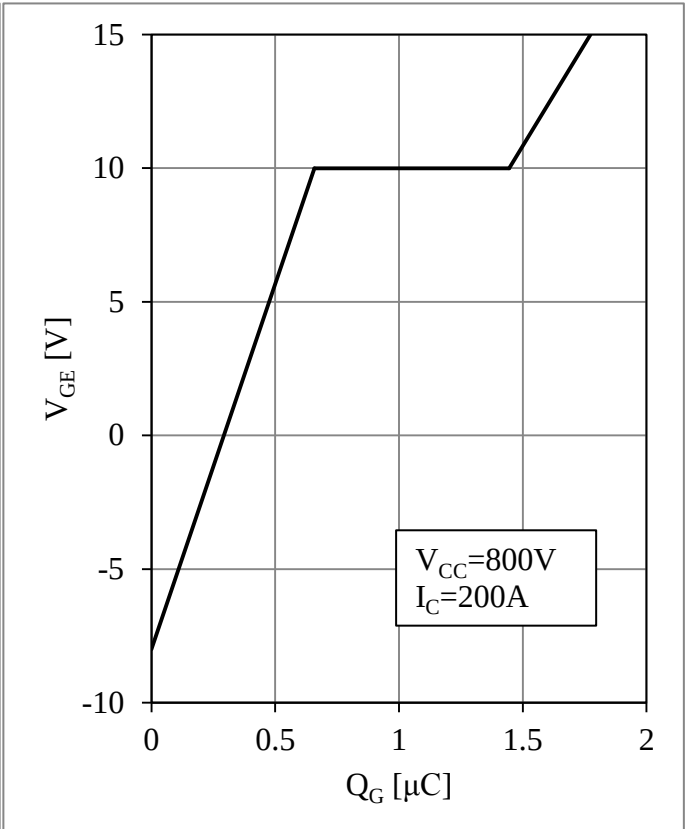
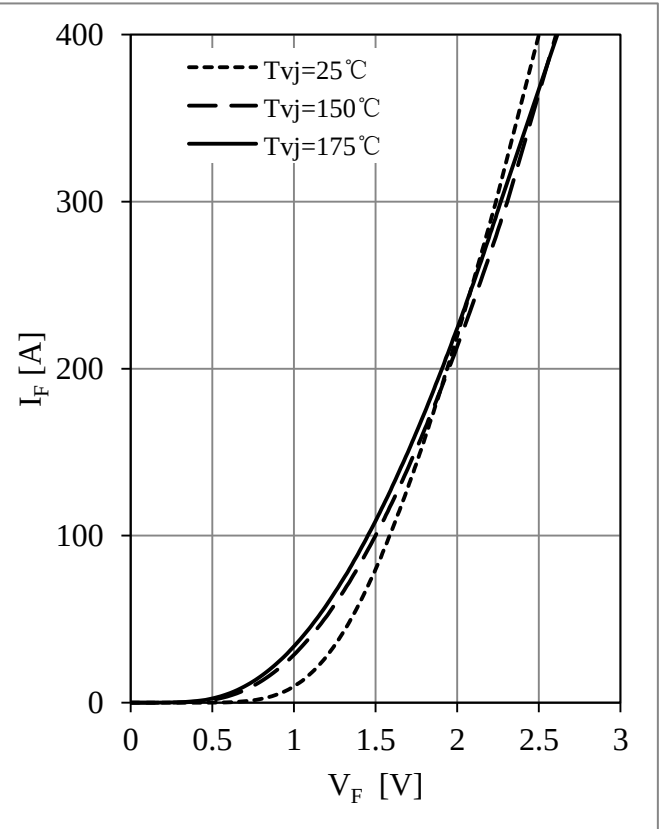
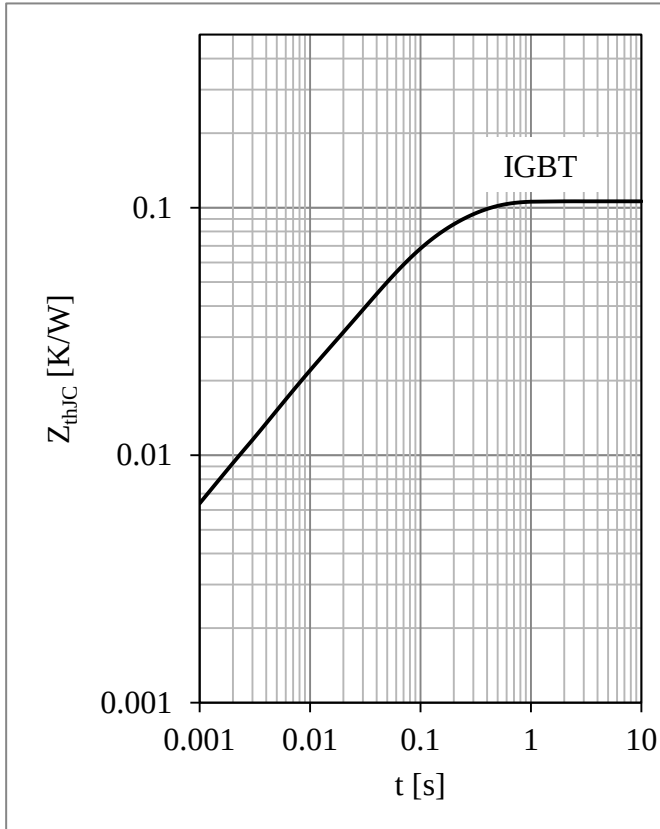
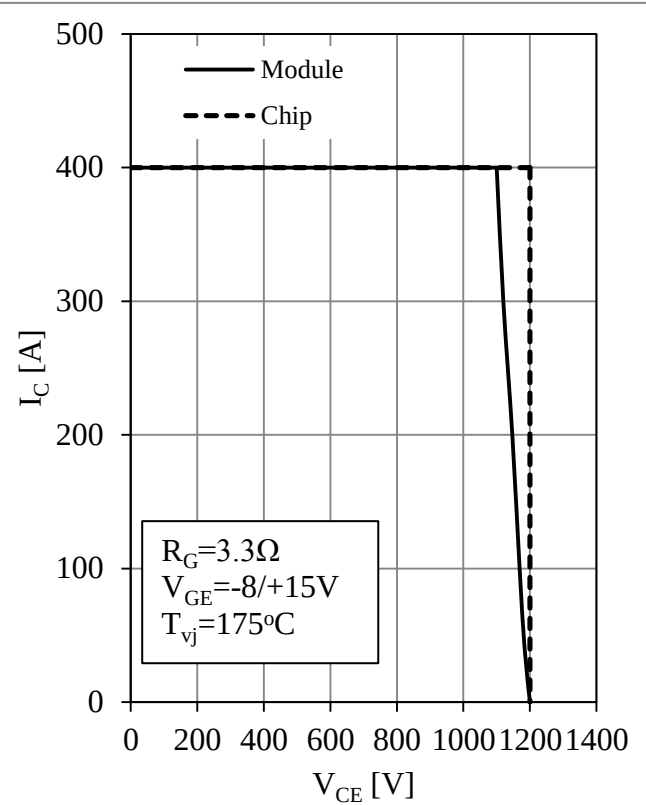
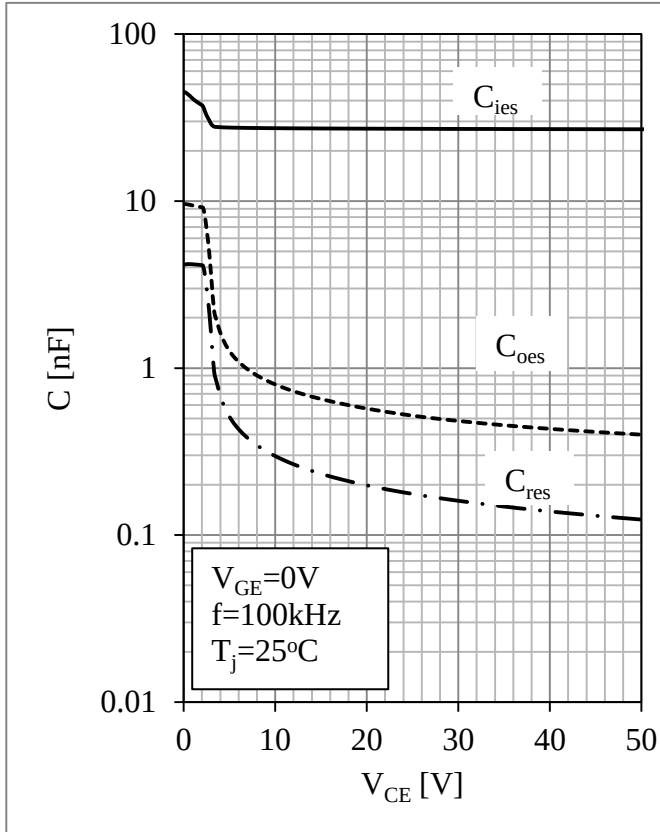
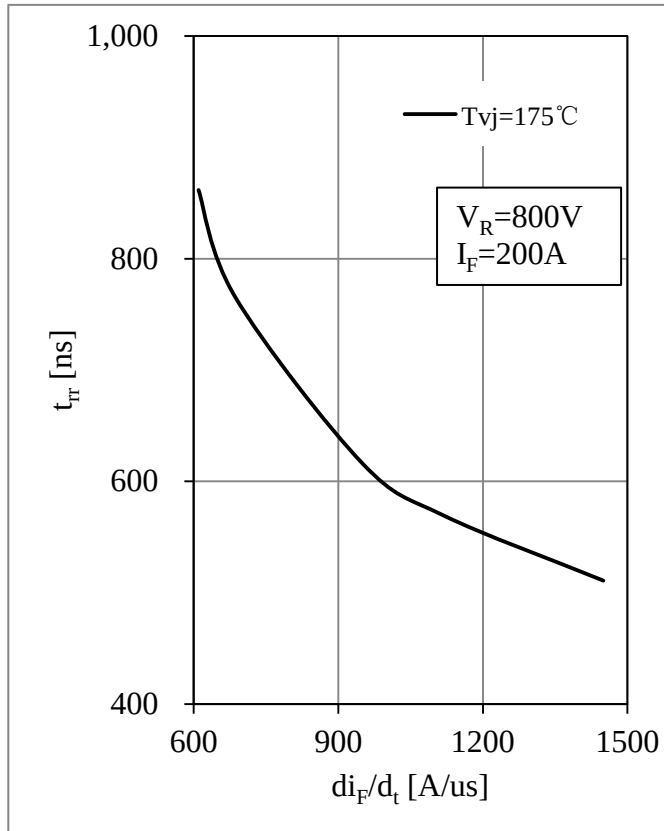
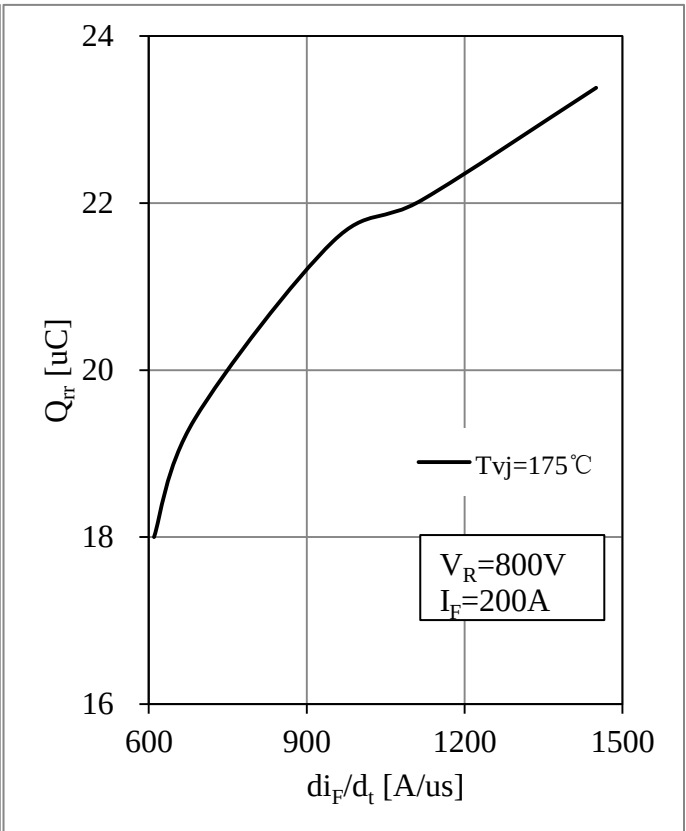
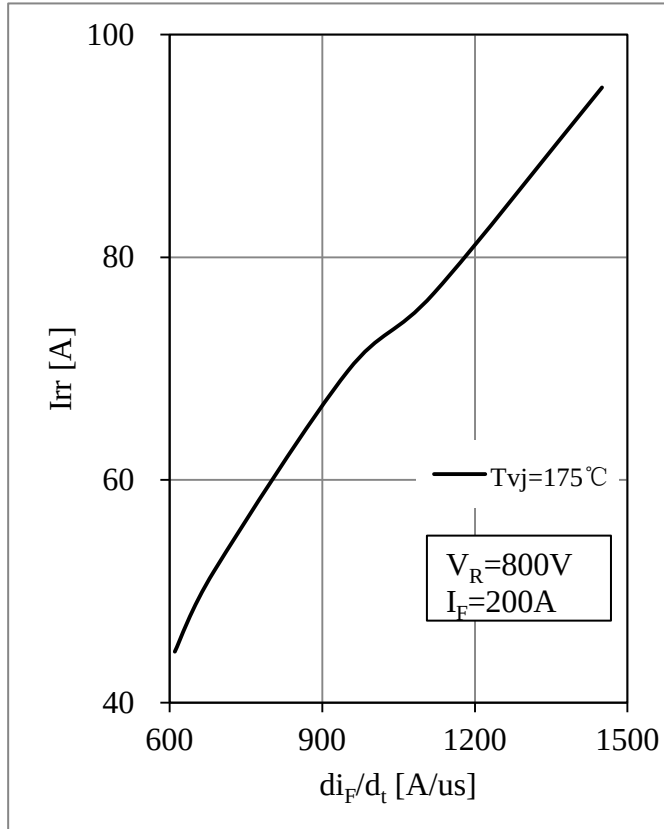
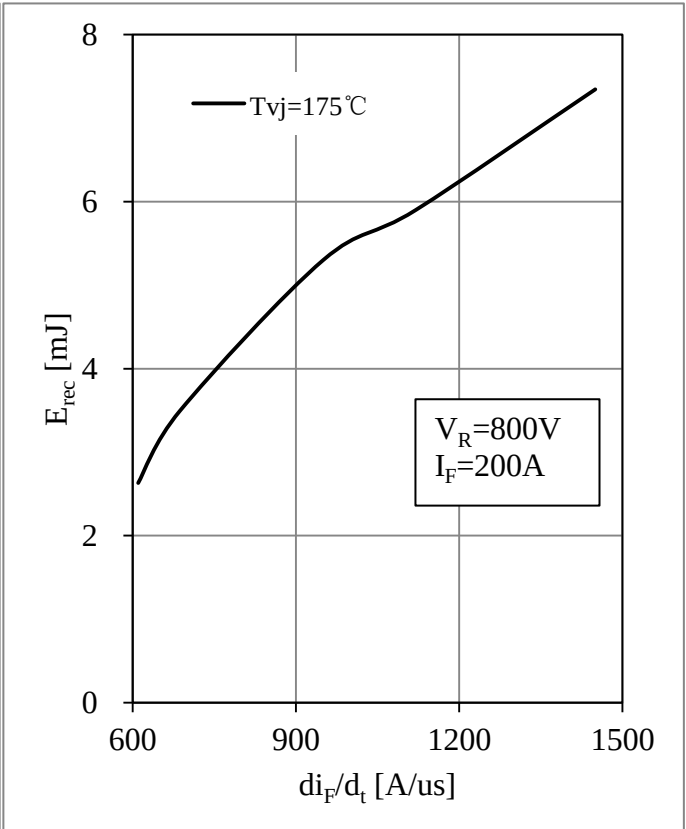
Fig 9. Switching Energy Loss vs. R_G Fig 10. Switching Energy Loss vs. T_j Fig 11. Switching Energy Loss vs. V_{CE} 

Fig 12. IGBT Gate Charge Characteristic



Fig 17. Reverse Recovery Time vs. di_F/d_t Fig 18. Reverse Recovery Charge vs. di_F/d_t Fig 19. Reverse Recovery Current vs. di_F/d_t Fig 20. Reverse Energy Losses vs. di_F/d_t

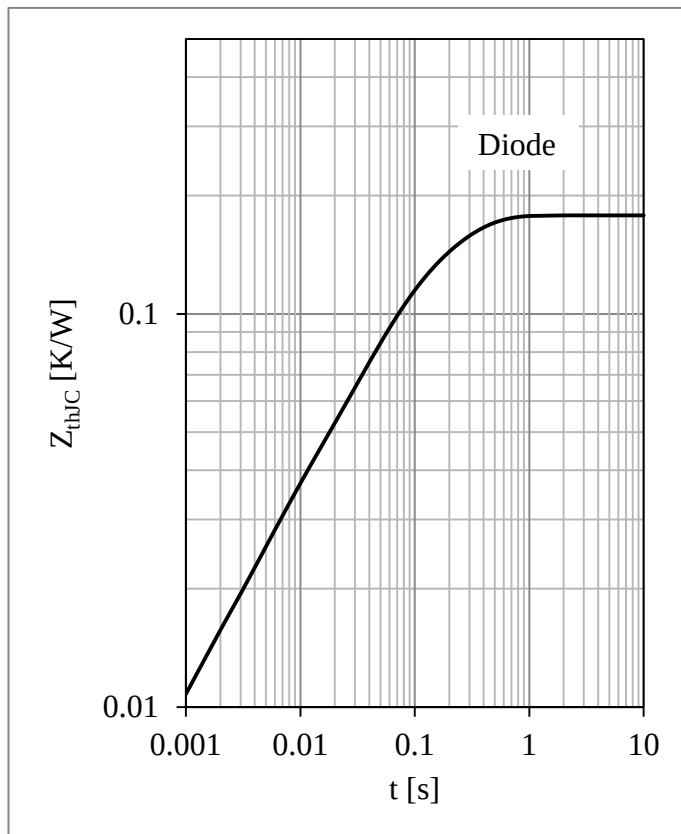
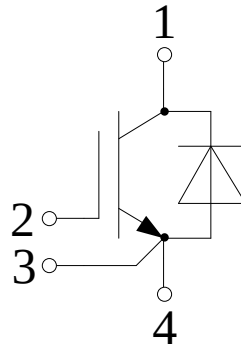


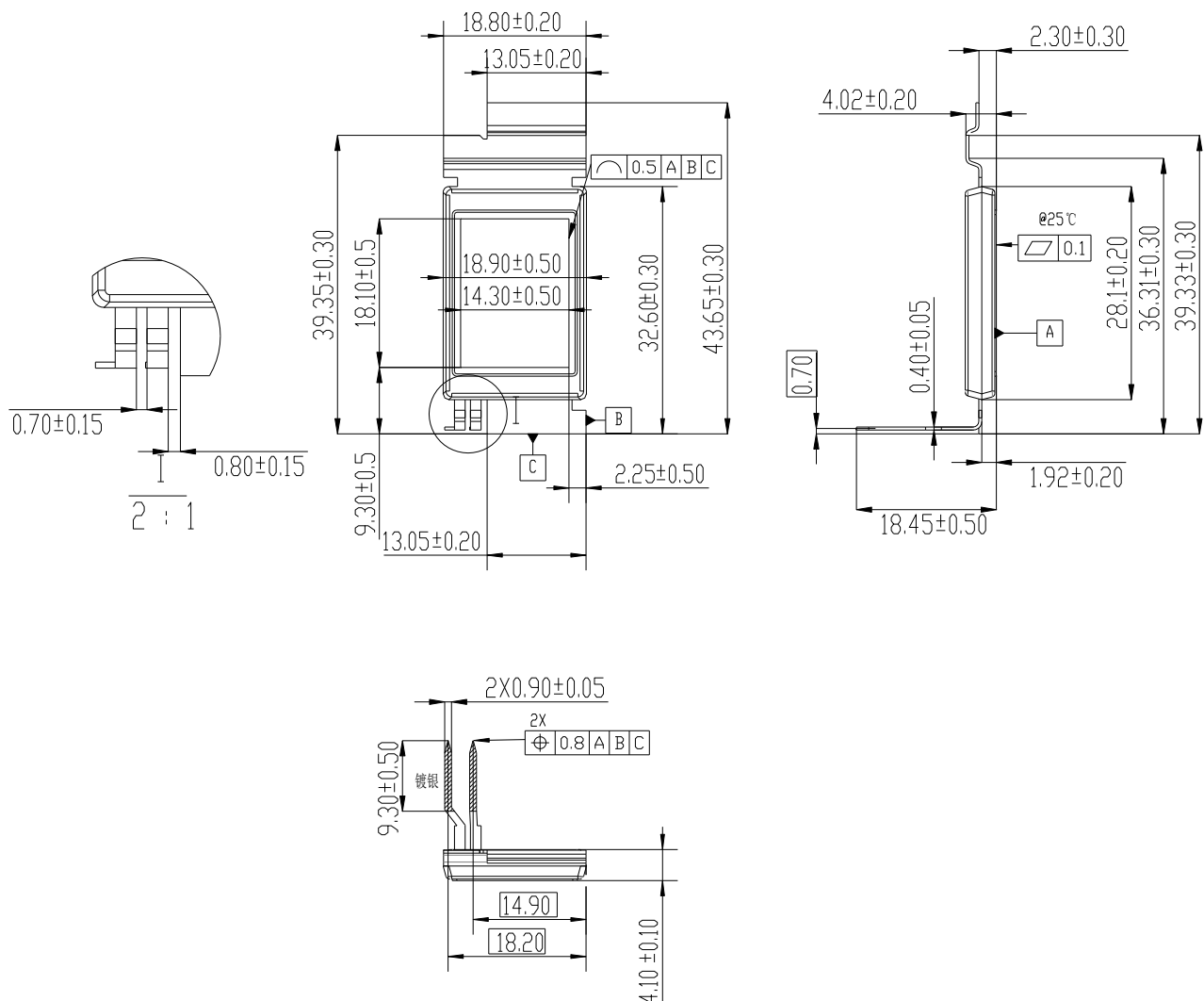
Fig 21. Diode Transient Thermal Impedance

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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